

## 6 - 18 GHz High Power Amplifier

### GaAs Monolithic Microwave IC

Preliminary

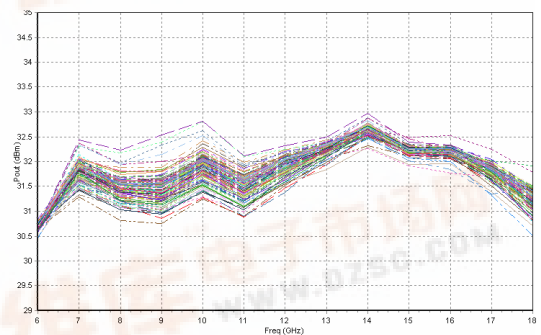
#### Description

The **CHA6517** is a Dual channel monolithic three-stage GaAs high power amplifier designed for wide band applications.

This device is manufactured using a UMS 0.25  $\mu\text{m}$  Power pHEMT process, including, via holes through the substrate and air bridges.

To simplify the assembly process:

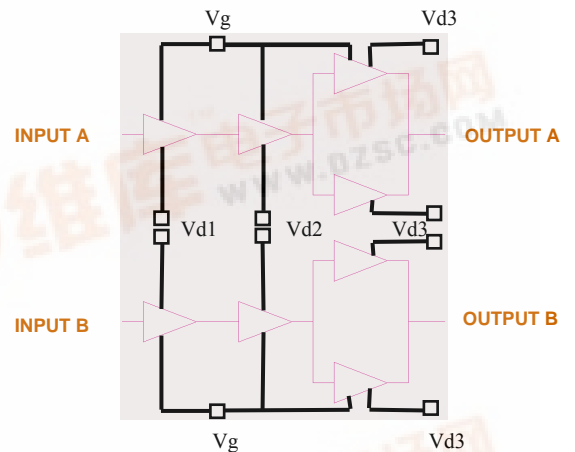
- the backside of the chip is both RF and DC grounded
- bond pads and back side are gold plated for compatibility with eutectic die attach method and thermosonic or thermocompression bonding process.



Output Power versus Frequency

#### Main Features

- 0.25  $\mu\text{m}$  Power pHEMT Technology
- 6 – 18 GHz Frequency Range
- 32dBm Output Power per channel
- Compatible for balanced configuration
- 22dB nominal Gain
- Quiescent Bias point : 600mA @ 8V per channel
- Chip size: 4.32 x 3.90 x 0.07 mm



#### Main Characteristics

Tamb = +25°C (Tamb is the back-side of the chip)

Symbol	Parameter	Min	Typ	Max	Unit
F_op	Operating frequency range	6		18	GHz
Psat	Saturated output power	30	32		dBm
G_lin	Linear gain	19	22		dB

## Electrical Characteristics

# Preliminary

Tamb = 25°C (2), Vd=8V, Id (Quiescent) = 0.6A, Pulsed biasing mode, each channel

Symbol	Parameter	Min	Typ	Max	Unit
F_op	Operating frequency	6		18	GHz
G_lin	Linear gain (Pin=-5dBm)	19	22		dB
RL_in	Input Return Loss		-14	-8	dB
RL_out	Output Return Loss		-8	-4	dB
Psat	Saturated output power (Pin=11dBm)	30	32		dBm
PAE_sat	Power Added Efficiency in saturation		15		%
Vd	Positive supply voltage		8		V
Id	Power supply quiescent current (1)		0.6		A
Vg	Negative supply voltage		-0.4		V
Top	Operating temperature range (2)	-40		+70	°C

- (1) This parameter is fixed by gate voltage Vg  
 (2) The reference is the back-side of the chip

## Absolute Maximum Ratings (1)

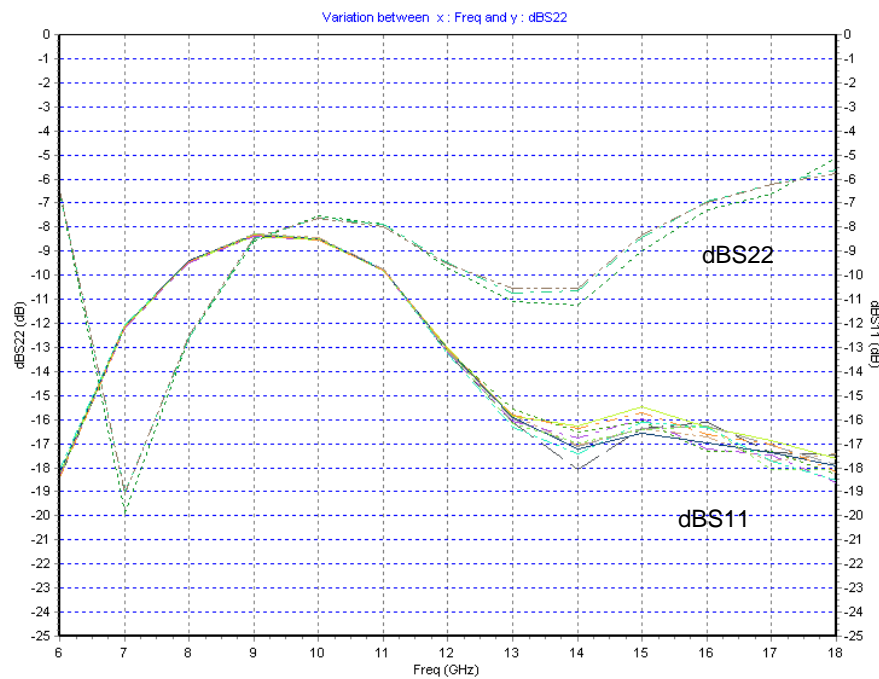
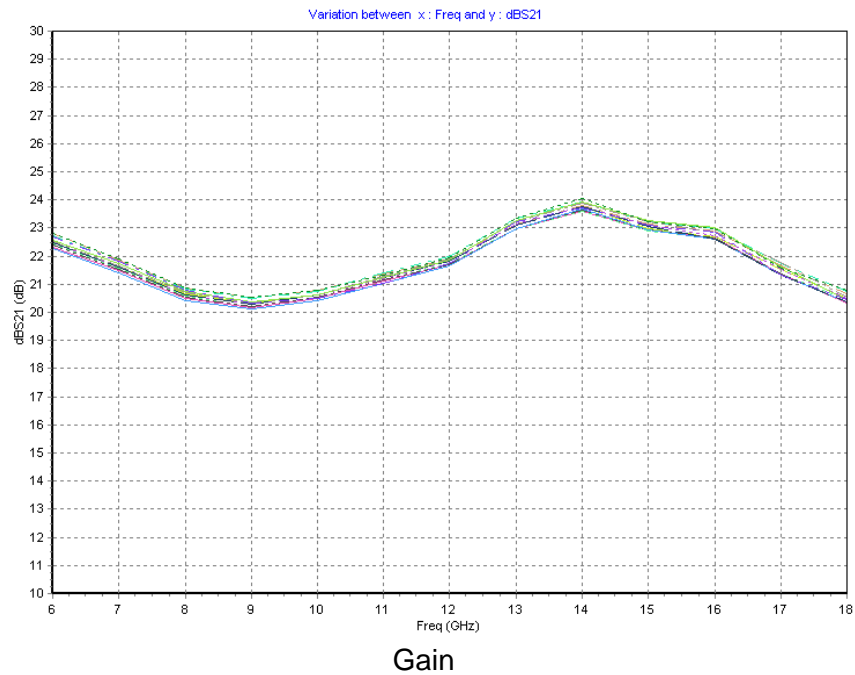
Symbol	Parameter	Values	Unit
Pin (2)	Maximum Input power	19	dBm
Vd (2)	Positive supply voltage without RF power	8.5	V
Id (2)	Positive supply quiescent current	1	A
Pd (2)	Power dissipation	13.5	W
Tj	Junction temperature	175	°C
Tstg	Storage temperature range	-55 to +125	°C

- (1) Operation of this device above anyone of these parameters may cause permanent damage.  
 (2) These values are specified for Tamb = 25°C

## Typical measured characteristics

Preliminary

On Wafer Measurements, S parameters (one channel):  
Tamb=25°C, Vd=8V, Id (Quiescent) = 0.6A, pulsed mo de:

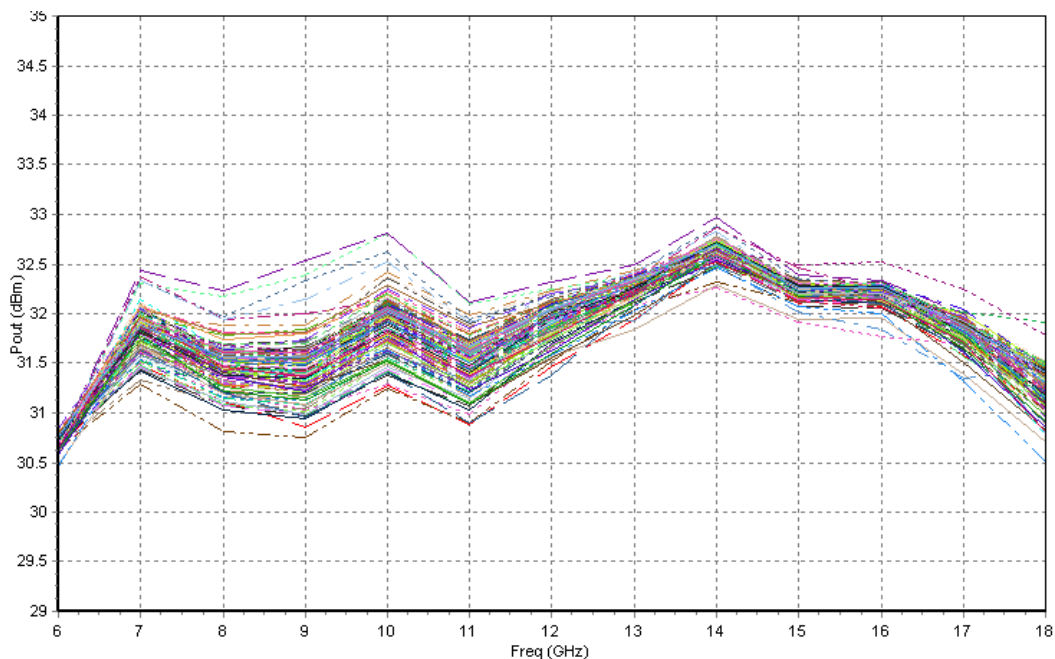


Input and Output Return losses

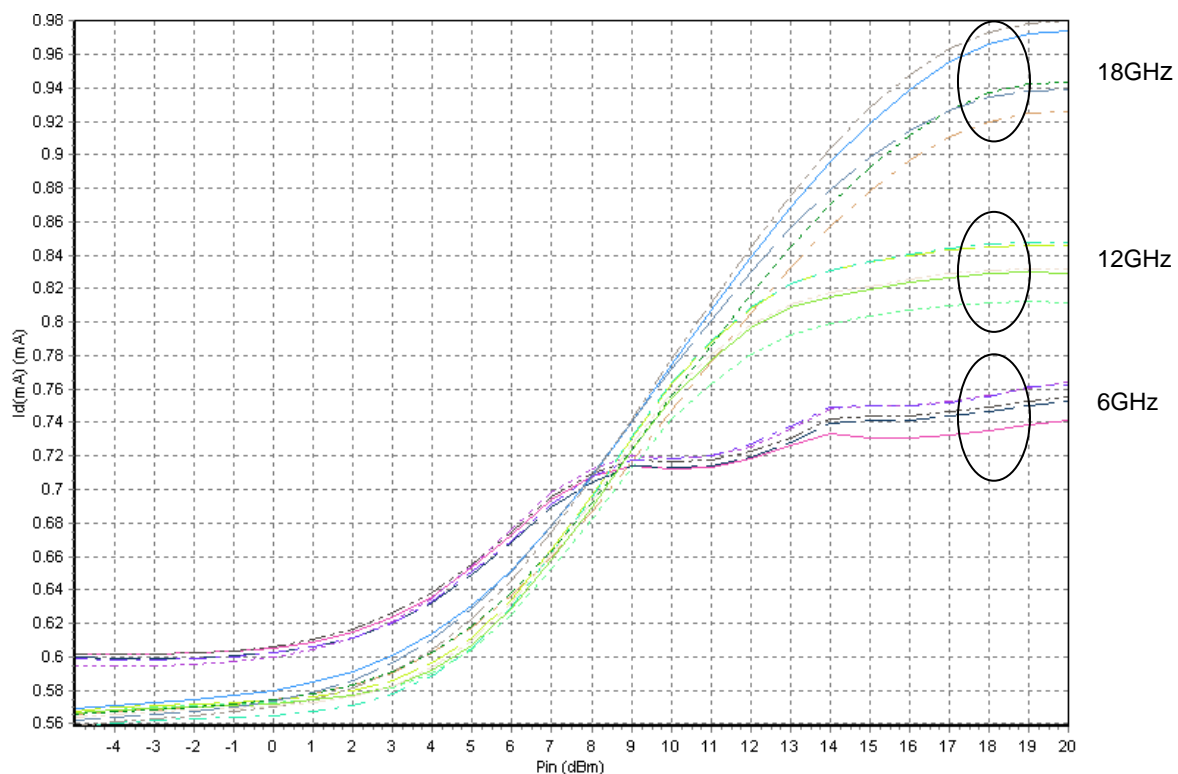
### On Wafer Measurements (one channel):

Tamb=25°C, Vd=8V, Id (Quiescent) = 0.6A, Pin=11dBm, pulsed mode:

# Preliminary



Output Power versus Frequency



Id versus Pin

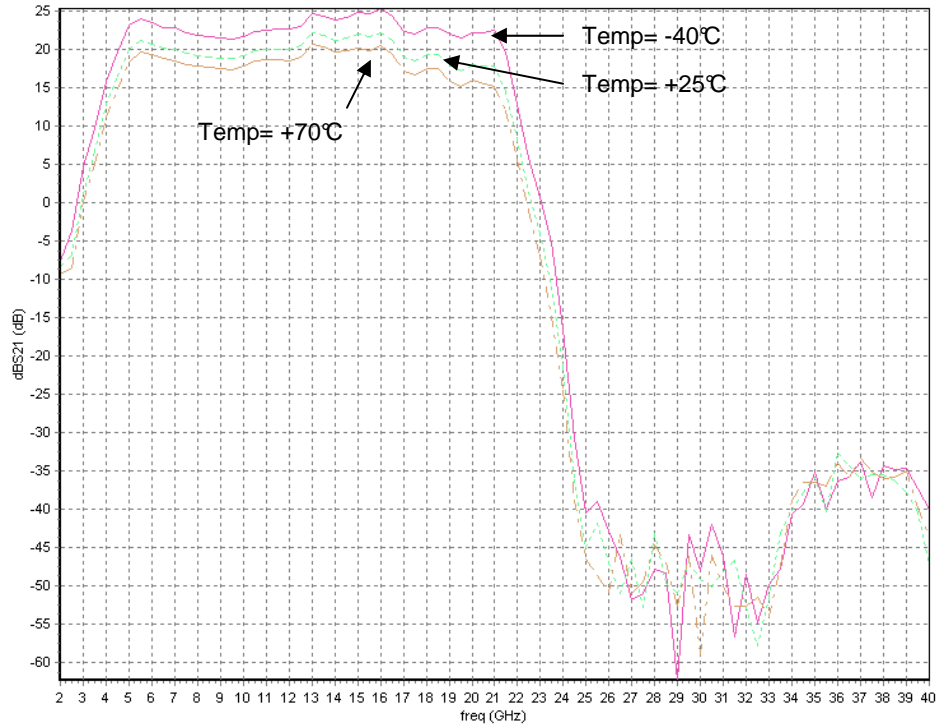
# X-band High Power Amplifier

# CHA6517

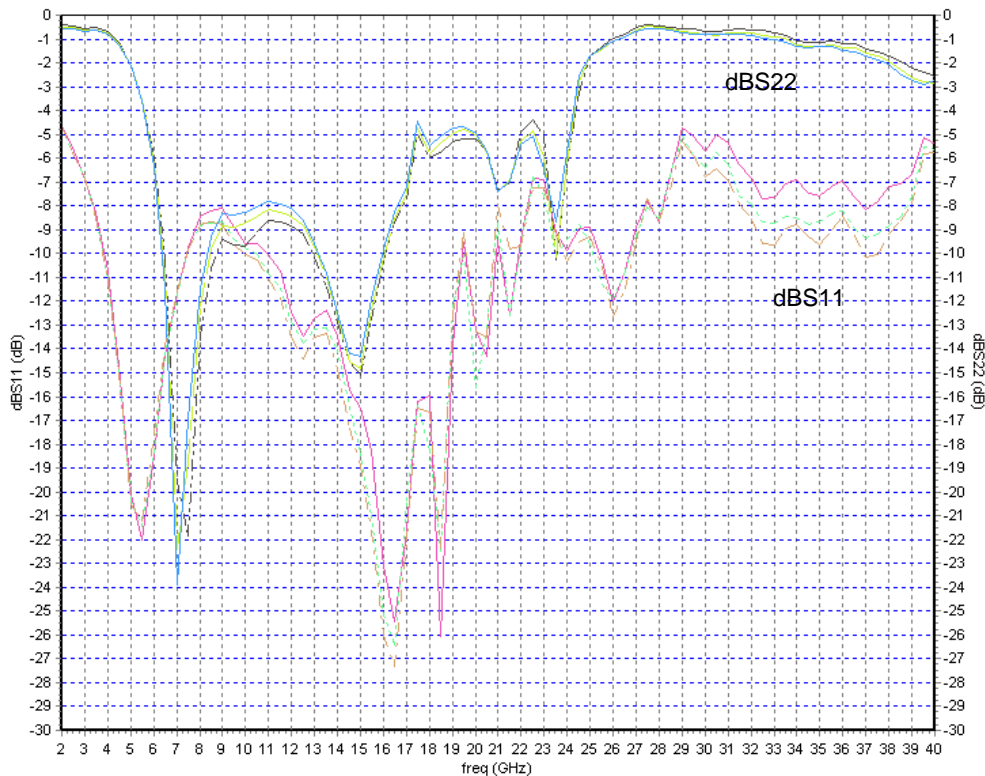
In test jig Measurements (one channel):

Vd=8V, Id (Quiescent) = 0.6A, S parameters, CW mode:

# Preliminary



Gain versus Frequency and Temperature (-40°C, +25°C and +70°C)

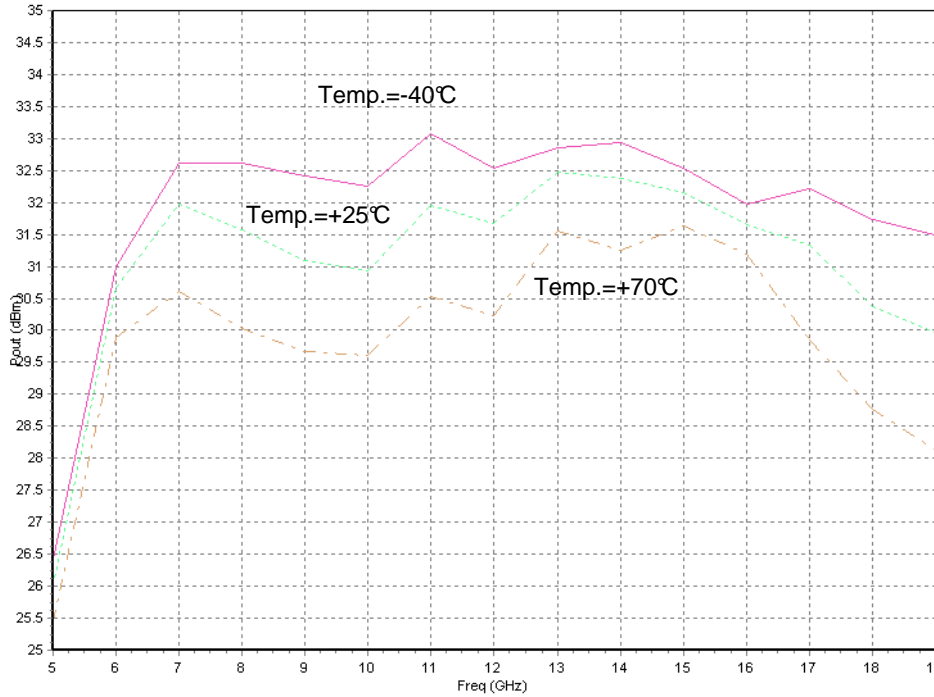


Input and Output Return losses versus Frequency and Temperature

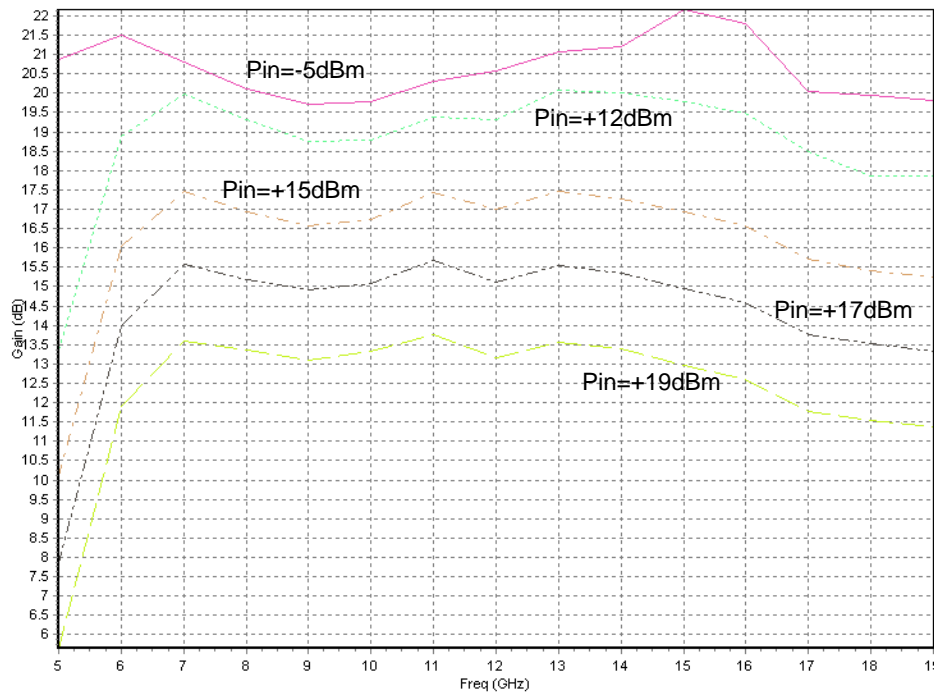
Preliminary

**In test jig Measurements (one channel):**

Vd=8V, Id (Quiescent) = 0.6A, Power measurements, CW mode

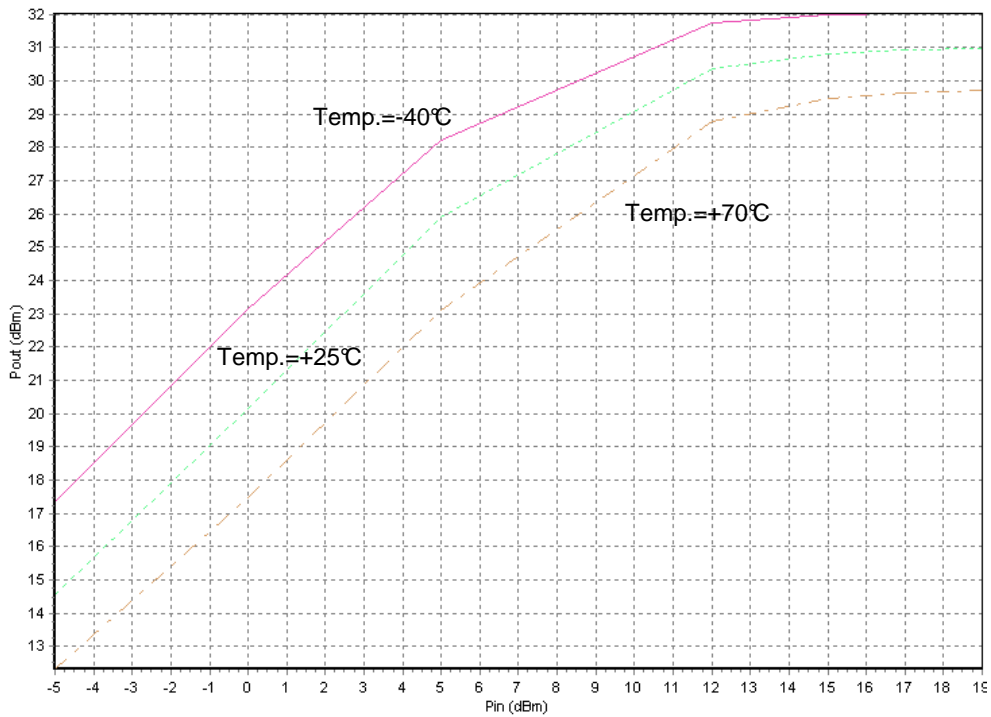


Output power versus Frequency and Temperature (Pin=+12dBm)

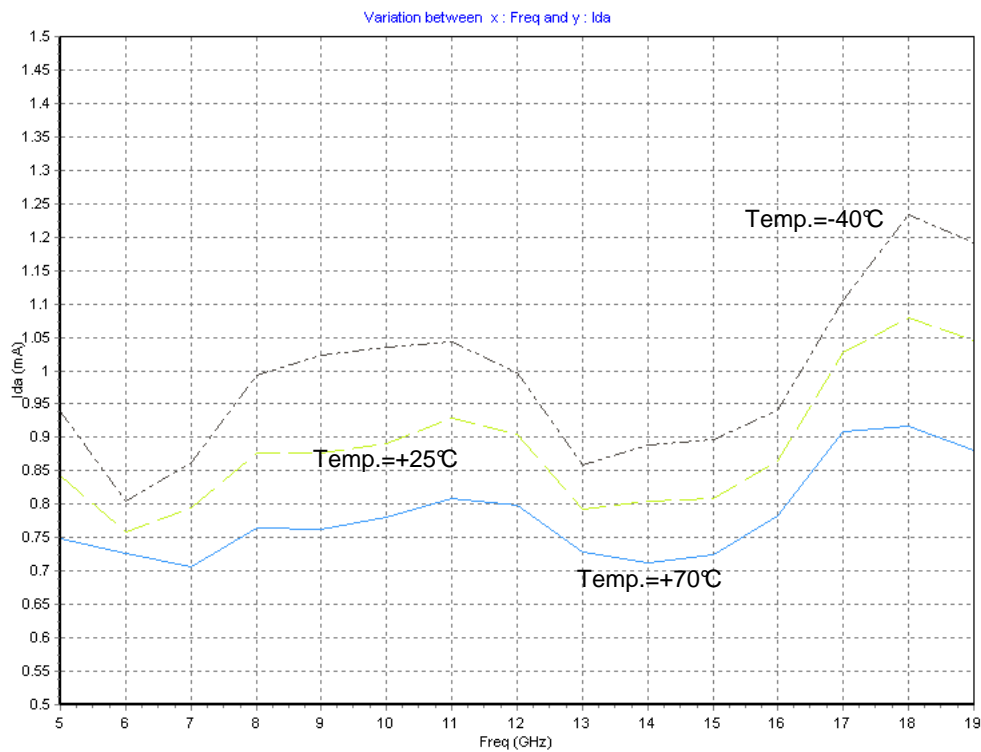


Gain versus Frequency and Input power (Temp.=+25°C)

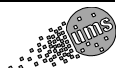
Preliminary



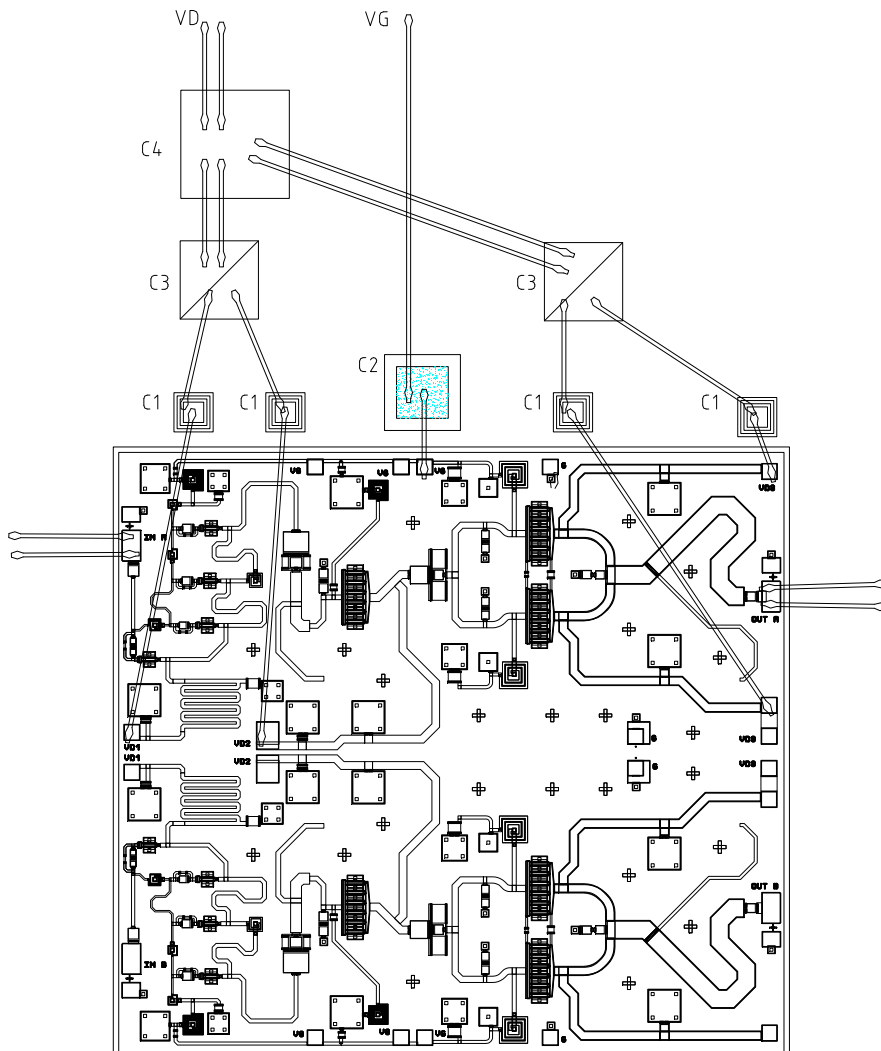
Output power versus Frequency and Temperature (Freq=18GHz)



Id current versus Frequency and Temperature (Pin=+17dBm)







## Assembly recommendations (one channel)

For thermal and electrical considerations, the chip should be brazed on a metal base plate. The RF and DC connections should be done according to the following table:

Port	Connection	External capacitor
IN (1, 22)	Inductance ( $L_{\text{bonding}}$ ) = 0.3nH	
OUT (7, 16)	Inductance ( $L_{\text{bonding}}$ ) = 0.3nH	
VD (6, 8, 10, 11, 12, 13, 15, 17)	Inductance $\leq$ 1nH	C1 ~ 22pF C3 ~ 1nF C4 ~ 100nF
VG (2, 3, 4, 19, 20, 21)	Inductance $\leq$ 1nH	C2 ~ 120pF

## Preliminary

### Ordering Information

Chip form : CHA6517-99F/00

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